



## Assessing MQXF Conductor Limits

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UNIGE (Nb<sub>3</sub>Sn wires (axial strain and transverse pressure)

Twente University – Nb<sub>3</sub>Sn cables (transverse pressure)

Florida State University – Nb<sub>3</sub>Sn wires (axial strain)



12<sup>th</sup> HL-LHC Collaboration Meeting, Uppsala - Sweden

19-22 September 2022

# MQXF Nb<sub>3</sub>Sn Wire

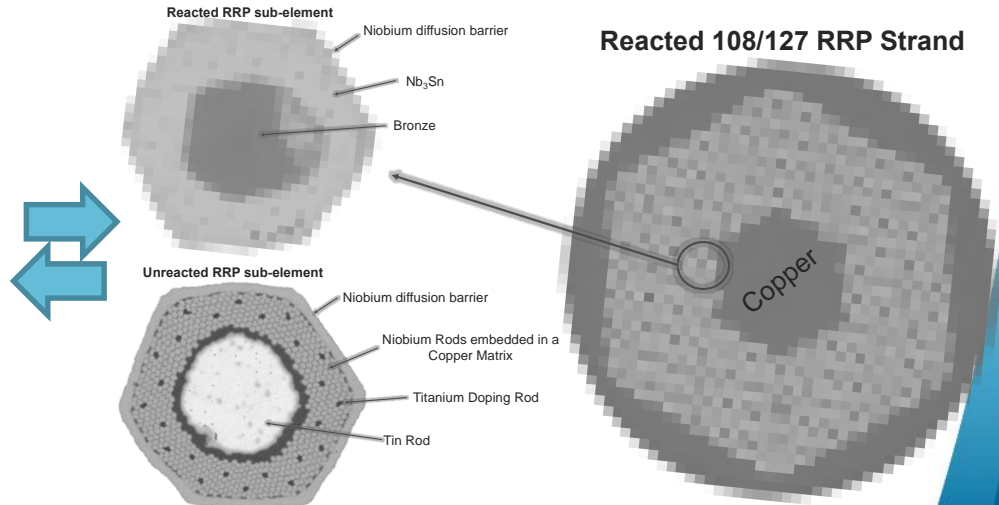
	Technology	# of subelements	Cu/non-Cu	Subelement size/shape	Diameter	I <sub>c</sub> (16 T)
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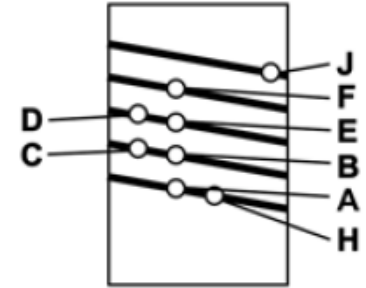
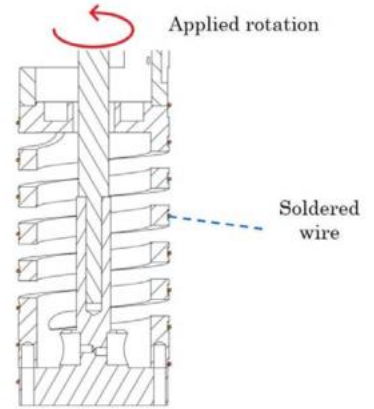
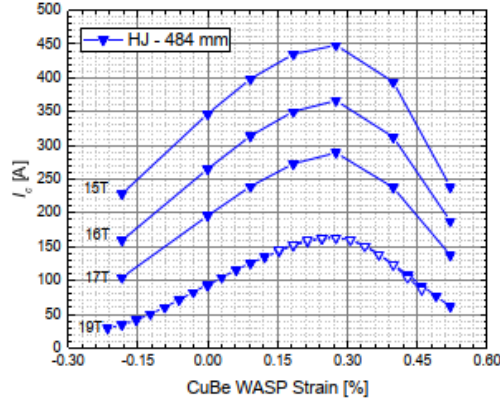
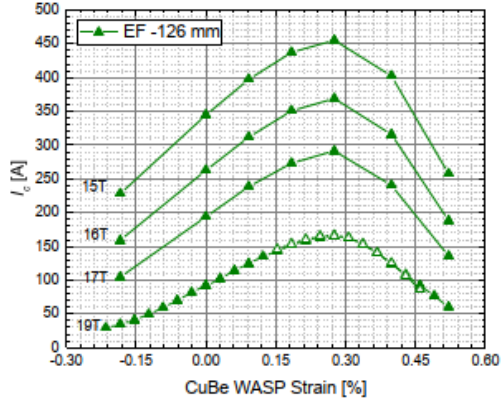
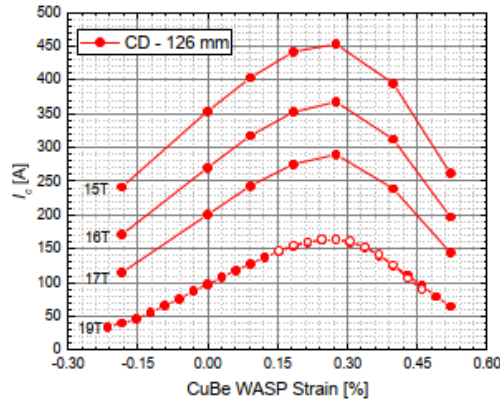
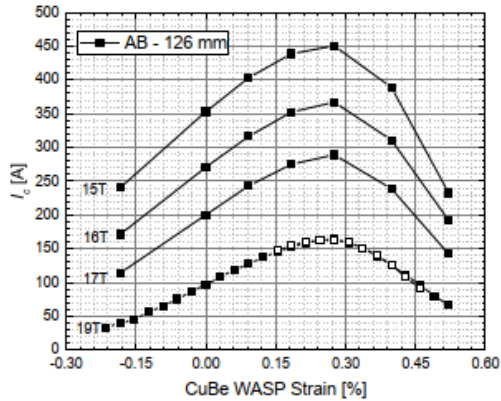
**RRP**      **108/127**      **1.2**      **~55 μm**      **0.85 mm**      **280 A**

## Heat treatment

HT N:	535	Code:	3_665_B
Furnace:	GERO_CERN163	Date:	13/09/2019
Plateau	T [°C]	Duration [h]	Ramp (up) rate [°C/h]
1	210	48	25
2	400	48	50
3	665	50	50



# Nb<sub>3</sub>Sn MQXF Wire – Axial Strain at 4.2 K



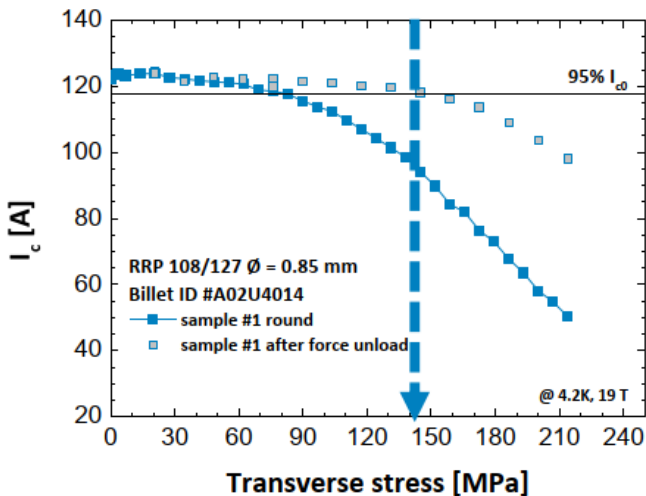
C-WASP, Unige

Measurements at University of Geneva

J. Ferradas Troitino et al, Supercond. Sci. Technol. **34** (2021) 035008 (10pp)

A. Ballarino

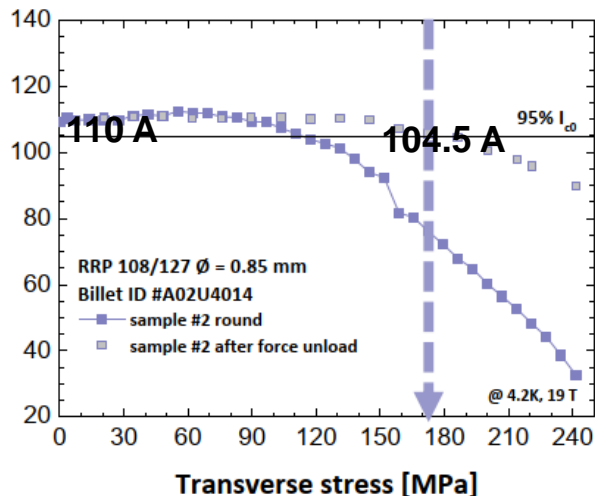
# Nb<sub>3</sub>Sn MQXF Wire - Transverse Pressure at 4.2 K



$$\sigma_{irr} = 145 \text{ MPa}$$

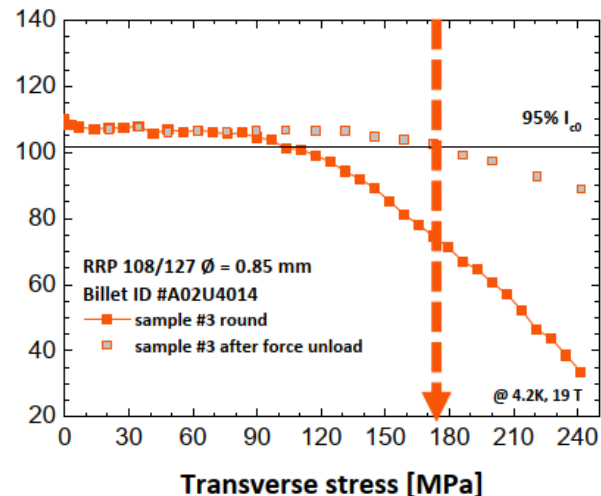
$$I_{co}(19 \text{ T}) = 124 \text{ A}$$

$\sigma_{irr} \rightarrow 5\% I_c$  reduction



$$\sigma_{irr} = 175 \text{ MPa}$$

$$I_{co}(19 \text{ T}) = 110 \text{ A}$$

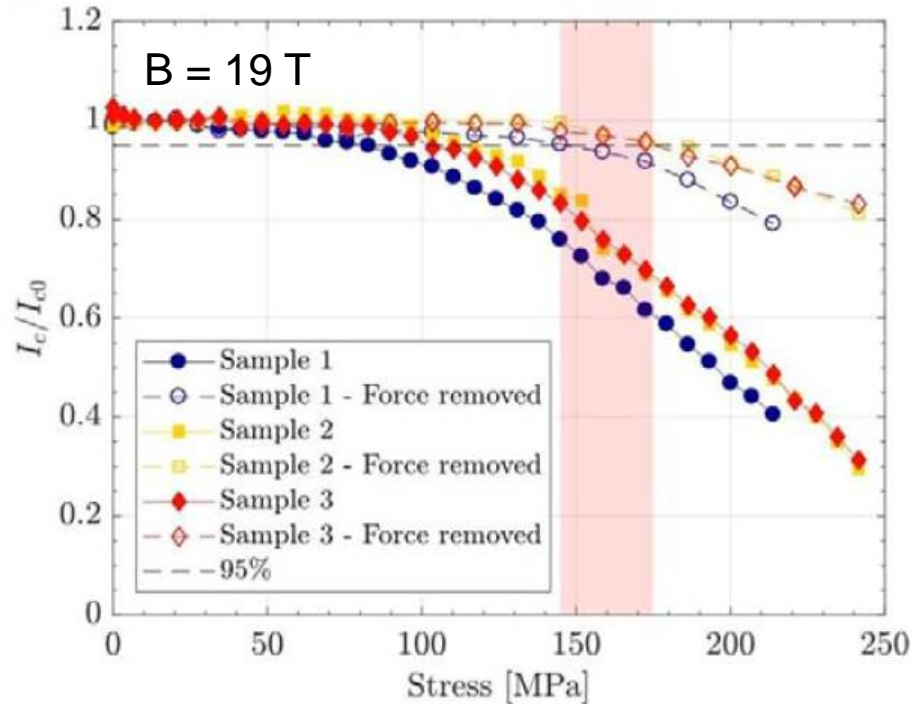


$$\sigma_{irr} = 175 \text{ MPa}$$

$$I_{co}(19 \text{ T}) = 107 \text{ A}$$

Measurements at University of Geneva

# Nb<sub>3</sub>Sn MQXF Wire - Transverse Pressure 4.2 K

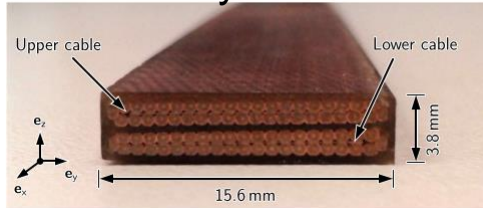


$\sigma_{irr} = 145 - 175$  MPa

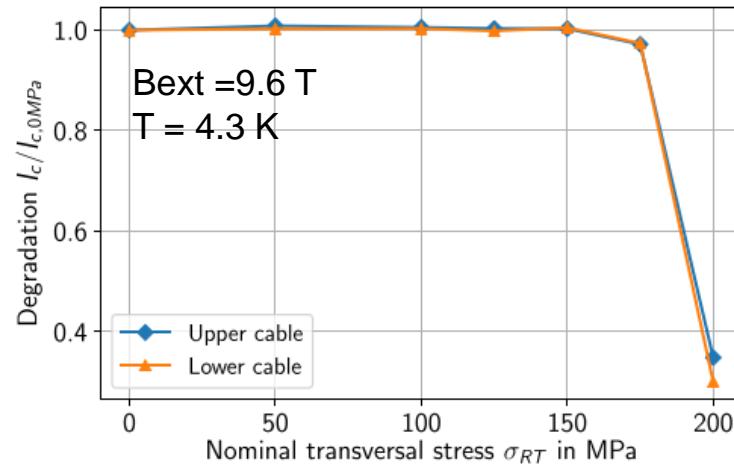
$I_c/I_{c0}$  @ 150 MPa = 16 % - 28 %

# Nb<sub>3</sub>Sn Cables under transverse pressure at RT

## 11 T forty-strand cable

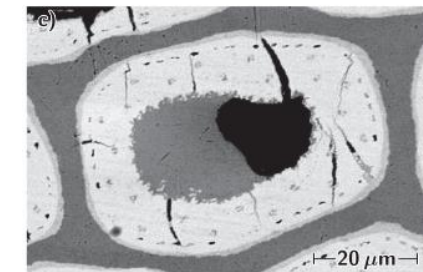
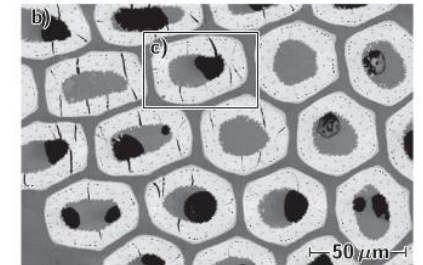
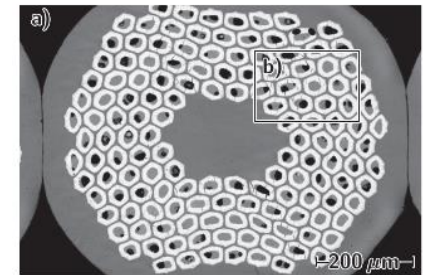


Manufacturer	CERN
Cable ID	HT15OC0190
Number of strands	40
Transposition pitch	100 mm
Keystone angle	0.79°
Mid-thickness	1.25 mm
Width	14.7 mm
Insulation	S-2 glass
Core	316 L
Packing factor	87.3%
Impregnation	CTD-101K



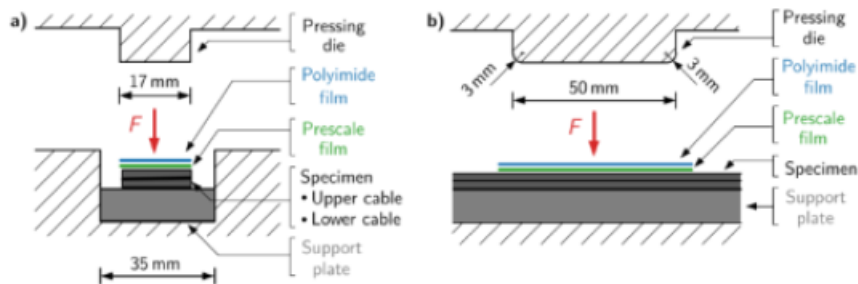
Crack initiation at 175 MPa

200 MPa



# Nb<sub>3</sub>Sn Cables under transverse pressure at RT

11 T forty-strand cable

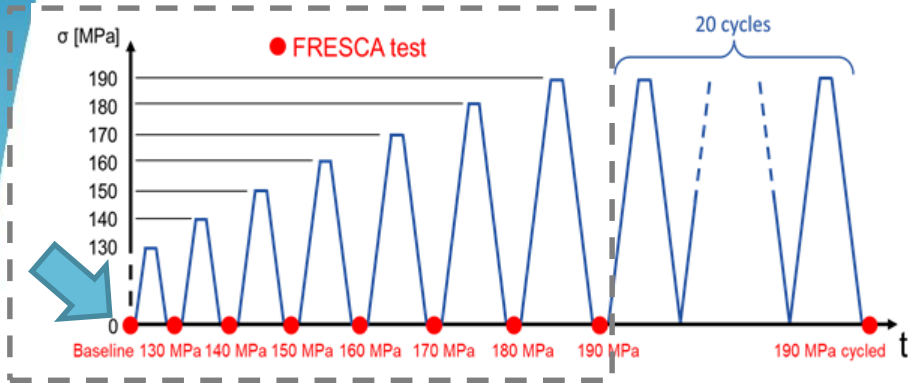


Cable configuration	
ID	H150C0220B
Number of strands	40
Transposition pitch	100 mm
Keystone	0.808 °
Mid-thickness	1.25 mm
Width	14.7 mm
Insulation	S-2 glass C-shaped MICA
Core material & dimensions	316L 24.3 μm x 12 mm
Impregnation	CTD-101K

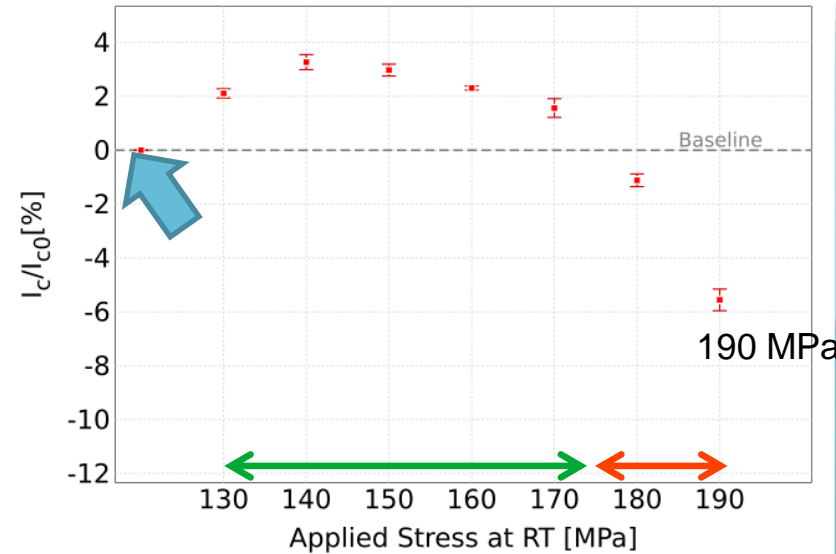
Two-cable stack configuration

Controlled pressure uniformly applied on cables

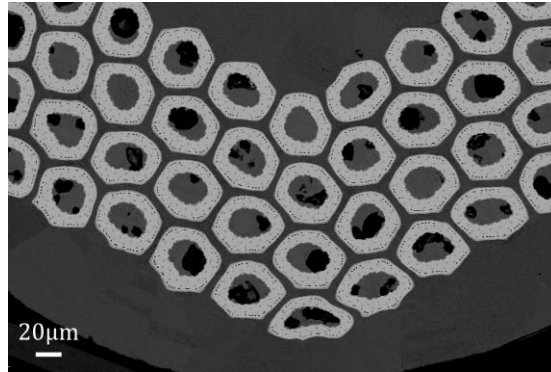
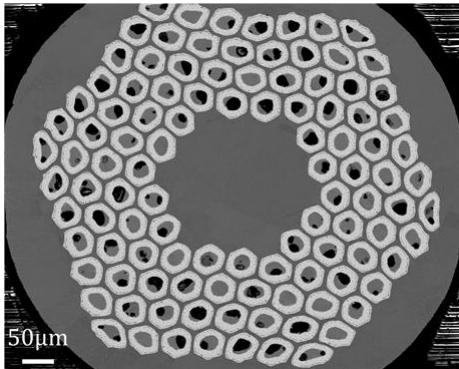
# Nb<sub>3</sub>Sn 11 T cables under transverse pressure at RT



## 11 T forty-strand cable



K. Puthran, Ch. Barth, G. Lenoir



Cross section of baseline cable

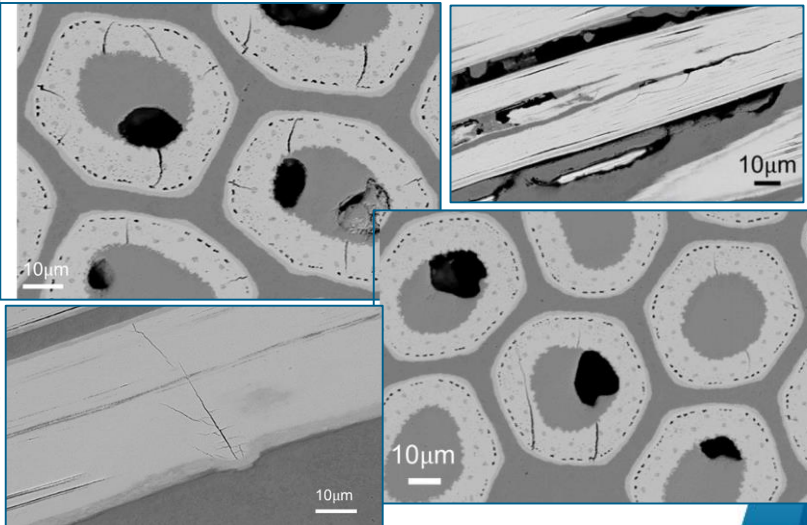
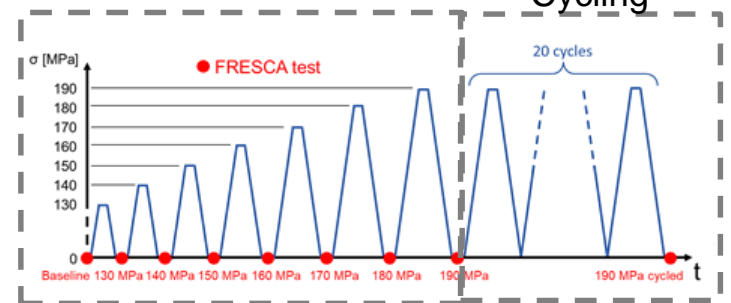
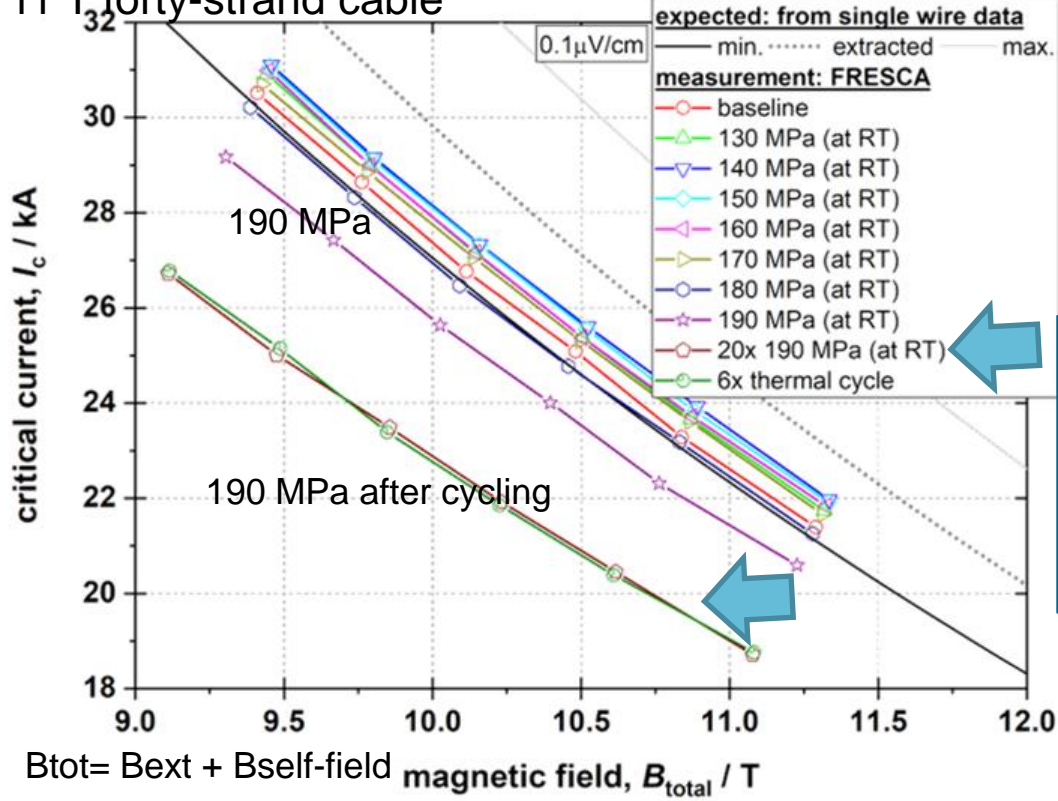


# Nb<sub>3</sub>Sn Cables under transverse pressure at RT



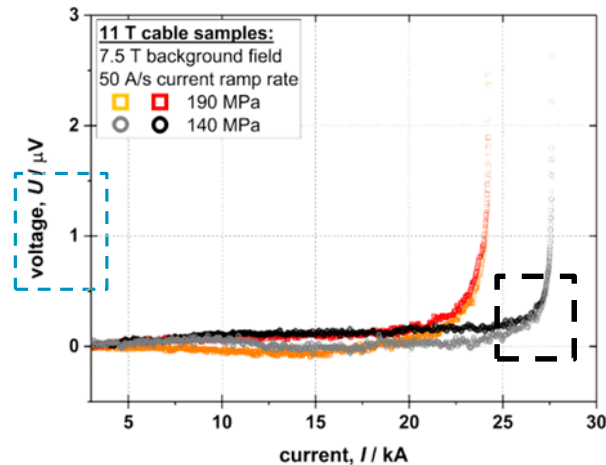
Cycling

11 T forty-strand cable



# Effect of micro-cracks

- Cracks generate a reduction of current carrying cross section
- Do cracks always generate a reduction of critical current ( $I_c$ ) ?  
**Narrow/micro cracks** even with high density but with a size that does not impact on current distribution and electrical connectivity in the superconducting filaments **may not be detectable** via  $I_c$  measurements, i.e. via V-I measurements

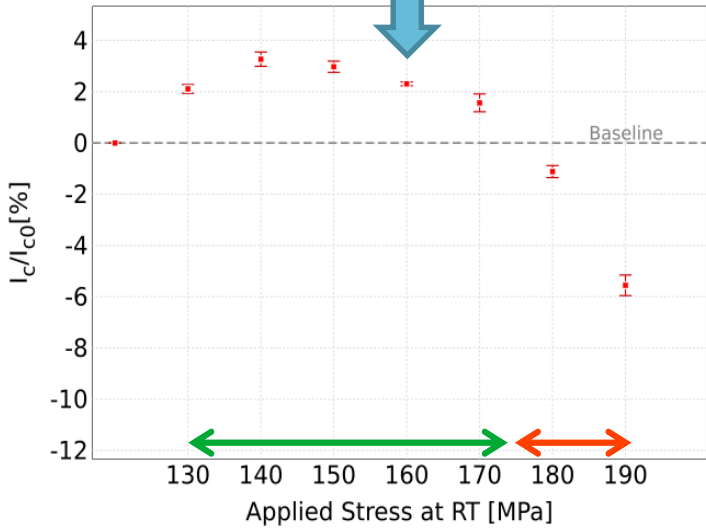


$$V(I) = E_c L \left(\frac{I}{I_c}\right)^n + \sum_i V_i$$

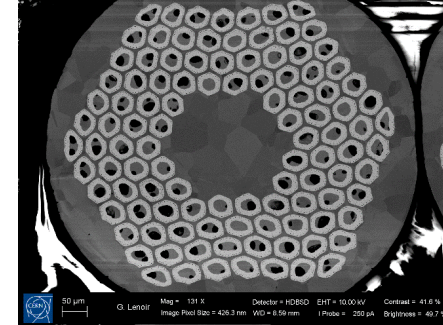
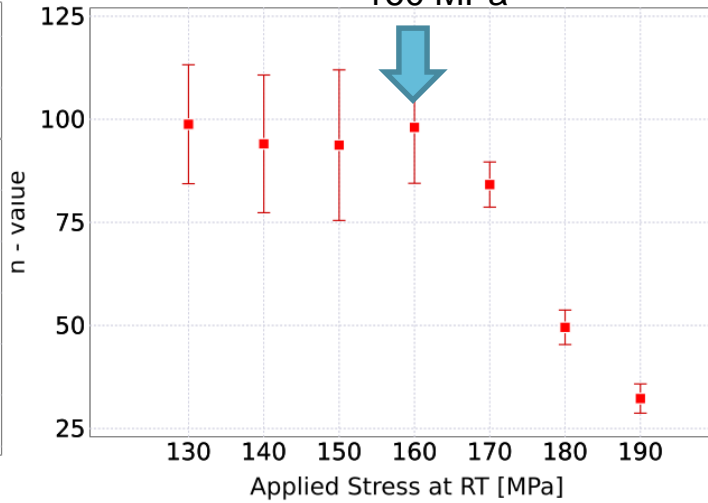
$$V_i = R_m I_{m,i}$$

# Effect of micro-cracks

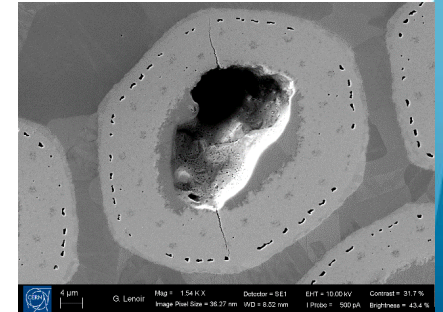
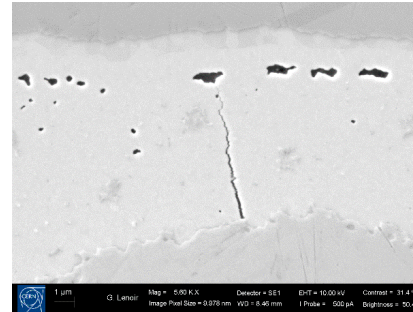
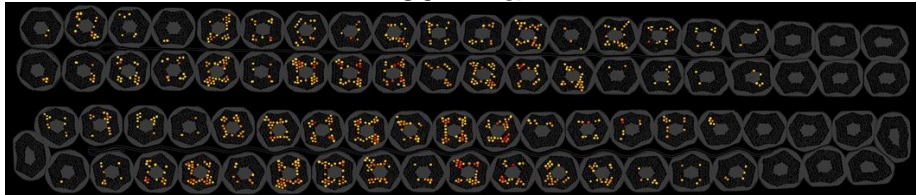
160 MPa



160 MPa



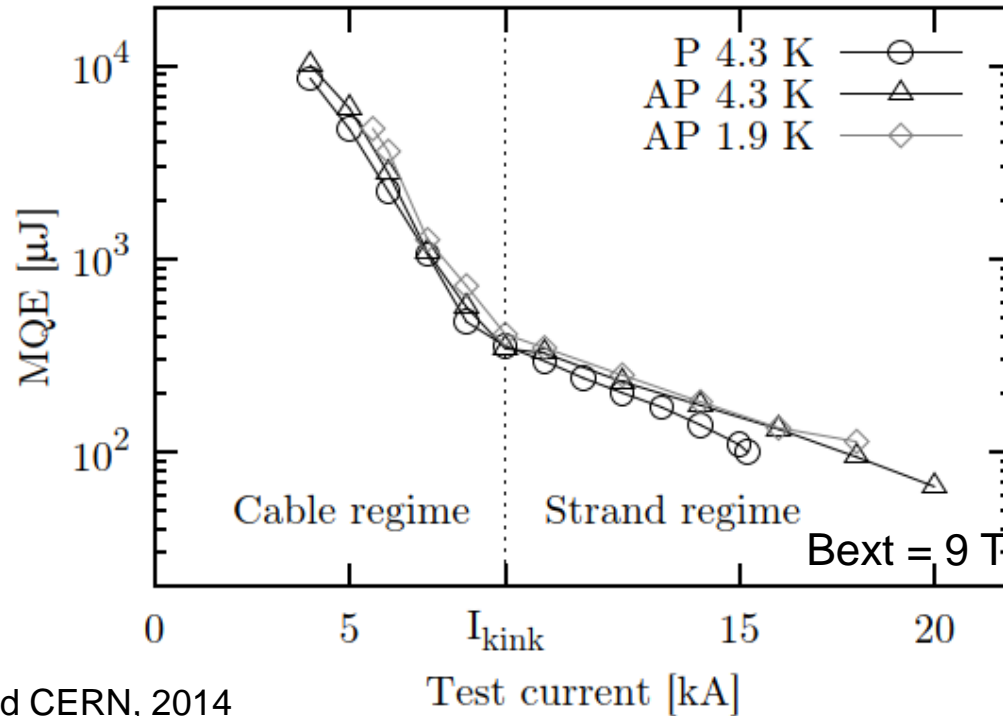
160 MPa



# Nb<sub>3</sub>Sn Cables: Thermal Stability

Collective strand behavior

Single strand behavior



W. D. Rapper

PhD Twente University and CERN, 2014



RRP Wire, 0.7 mm diameter, 27 strands



***Thanks for your attention !***

